



Features

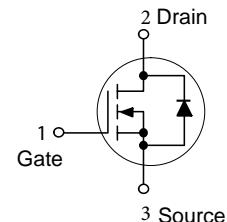
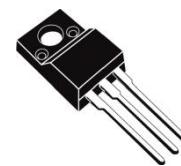
- DC-fast switching
- ESD improved capability
- Low on resistance
- Low gate charge
- Low reverse transfer capacitances
- 100% single pulse avalanche energy test
- $V_{DSS}=600V$

$I_D=7A$

$P_D=40W$

$R_{DS(on)(TYP)}=0.9\Omega$

TO-220F



Applications

- Power switch circuit of adaptor and charger

Absolute Maximum Ratings ($T_c=25^\circ C$ unless otherwise stated)

Symbol	Parameter	Rating	Units
V_{DSS}	Drain-to-Source Voltage	600	V
I_D	Continuous Drain Current	7	A
	Continuous Drain Current $T_c=100^\circ C$	4.5	A
I_{DM}^{a1}	Pulsed Drain Current	28	A
V_{GS}	Gate-to-Source Voltage	± 30	V
E_{AS}^{a2}	Single Pulse Avalanche Energy	560	mJ
E_{Ar}^{a1}	Avalanche Energy ,Repetitive	54	mJ
I_{AR}^{a1}	Avalanche Current	3.3	A
dv/dt^{a3}	Peak Diode Recovery dv/dt	5.0	V/ns
P_D	Power Dissipation	40	W
	Derating Factor above $25^\circ C$	0.32	W/ $^\circ C$
$V_{ESD(GS)}$	Gate source ESD (HBM-C= 100pF, $R=1.5k\Omega$)	3000	V
T_J, T_{stg}	Operating Junction and Storage Temperature Range	150 , -55 to 150	$^\circ C$
T_L	Maximum Temperature for Soldering	300	$^\circ C$

a1 : Repetitive rating; pulse width limited by maximum junction temperature

a2 : $L=10mH$, $I_D=11A$, Start $T_J=25^\circ C$

a3 : $I_{SD}=7A$, $dI/dt \leq 100A/\mu s$, $V_{DD} \leq BV_{DS}$, Start $T_J=25^\circ C$



Thermal Characteristics

Symbol	Parameter	Rating	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	3.13	°C / W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	100	°C / W

Electrical Characteristics ($T_C=25^\circ C$ unless otherwise specified)

Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
Off Characteristics						
V_{DSS}	Drain to Source Breakdown Voltage	$V_{GS}=0V, I_D=250\mu A$	600	--	--	V
$\Delta BV_{DSS}/\Delta T_J$	Bvdss Temperature Coefficient	$I_D=250\mu A$, Reference $25^\circ C$	--	0.61	--	V/°C
I_{DSS}	Drain to Source Leakage Current	$V_{DS}=600V, V_{GS}=0V, T_a=25^\circ C$	--	--	10	μA
		$V_{DS}=480V, V_{GS}=0V, T_a=125^\circ C$	--	--	100	
$I_{GSS(F)}$	Gate to Source Forward Leakage	$V_{GS}=+20V$	--	--	10	μA
$I_{GSS(R)}$	Gate to Source Reverse Leakage	$V_{GS}=-20V$	--	--	-10	μA
On Characteristics						
$R_{DS(ON)}$	Drain-to-Source On-Resistance	$V_{GS}=10V, I_D=3.5A$	--	0.9	1.2	Ω
$V_{GS(TH)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu A$	2.0	--	4.0	V
g_{fs}	Forward Trans conductance	$V_{DS}=15V, I_D=3.5A$	--	5	--	S
Pulse width < 380μs; duty cycle < 2%.						
Dynamic Characteristics						
C_{iss}	Input Capacitance	$V_{GS}=0V, V_{DS}=25V, f=1.0MHz$	--	950	--	pF
C_{oss}	Output Capacitance		--	98	--	
C_{rss}	Reverse Transfer Capacitance		--	10	--	
Resistive Switching Characteristics						
$t_{d(ON)}$	Turn-on Delay Time	$I_D=7A, V_{DD}=325V$ $V_{GS}=10V, R_g=9.1\Omega$	--	11	--	ns
t_r	Rise Time		--	10	--	
$t_{d(OFF)}$	Turn-Off Delay Time		--	36	--	
t_f	Fall Time		--	18	--	
Q_g	Total Gate Charge	$I_D=7A, V_{DD}=325V$ $V_{GS}=10V$	--	25	--	nC
Q_{gs}	Gate to Source Charge		--	4	--	
Q_{gd}	Gate to Drain ("Miller") Charge		--	10	--	
Source-Drain Diode Characteristics						
I_{SD}	Continuous Source Current (Body Diode)	$I_s=7A, V_{GS}=0V$ $I_s=7A, T_J=25^\circ C$ $dI_F/dt=100A/\mu s, V_{GS}=0V$	--	--	7	A
I_{SM}	Maximum Pulsed Current (Body Diode)		--	--	28	A
V_{SD}	Diode Forward Voltage		--	--	1.5	V
t_{rr}	Reverse Recovery Time		--	201	--	ns
Q_{rr}	Reverse Recovery Charge		--	989	--	nC
Pulse width < 380μs; duty cycle < 2%.						



Typical Characteristic Curves

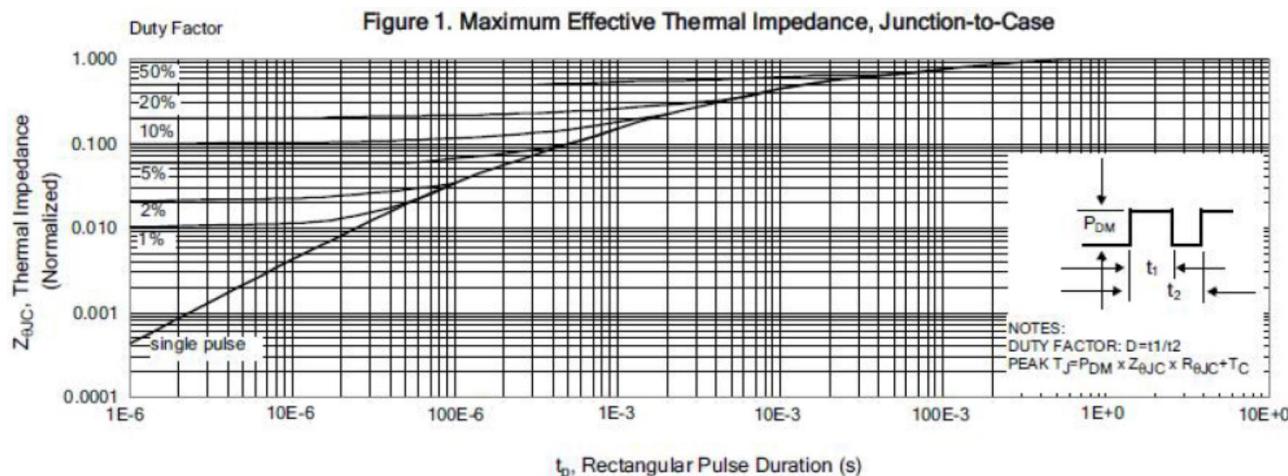


Figure 2. Maximum Power Dissipation vs Case Temperature

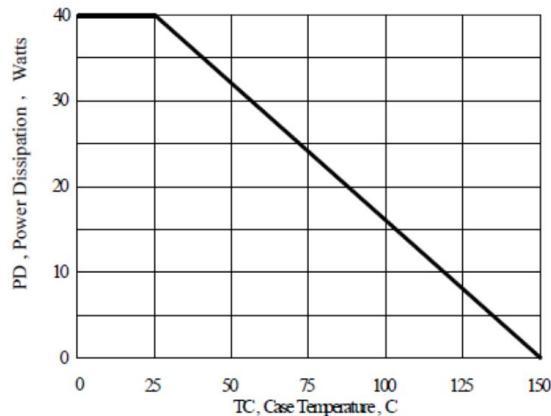


Figure 4. Typical Output Characteristics

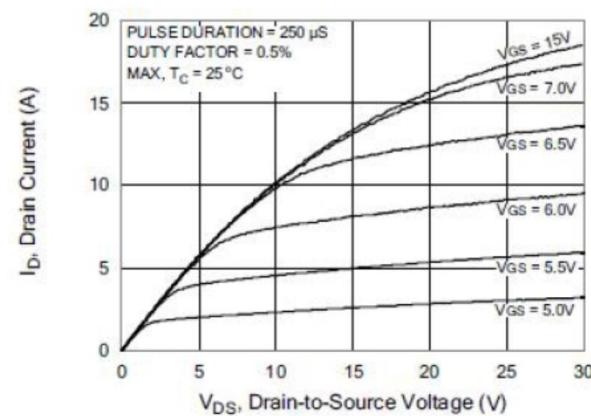


Figure 3. Maximum Continuous Drain Current vs Case Temperature

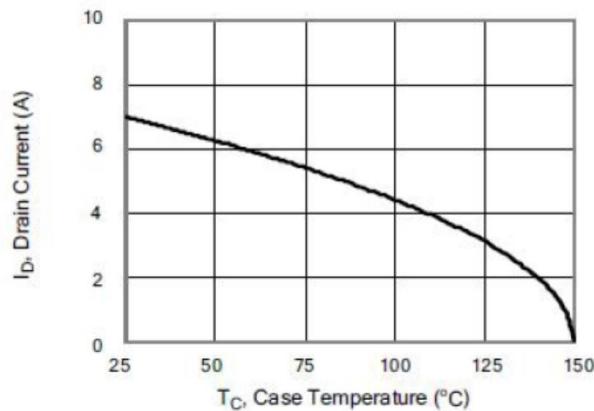


Figure 5. Typical Drain-to-Source ON Resistance vs Gate Voltage and Drain Current

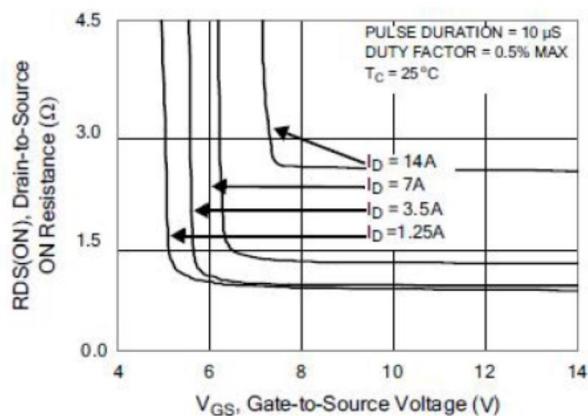




Figure 6. Maximum Peak Current Capability

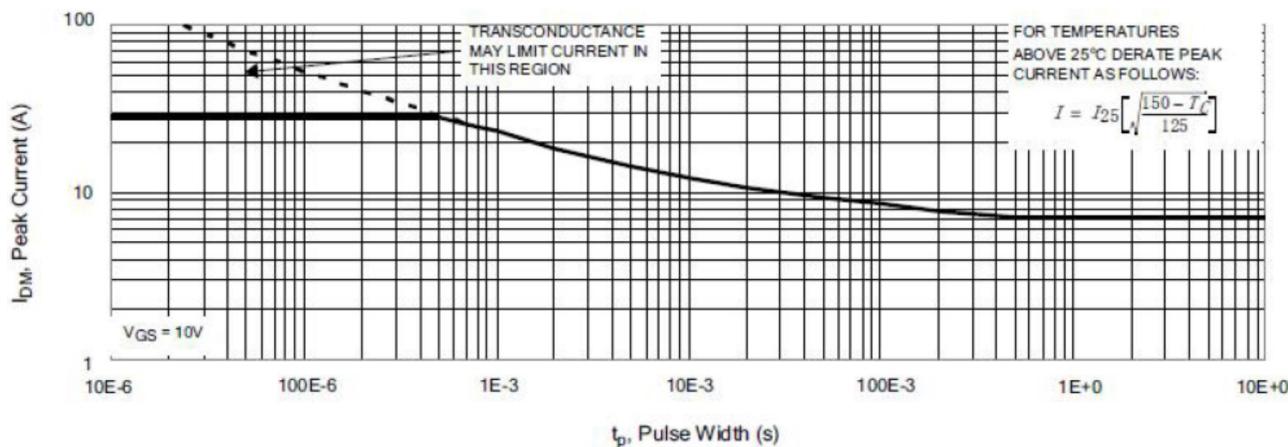


Figure 7. Typical Transfer Characteristics

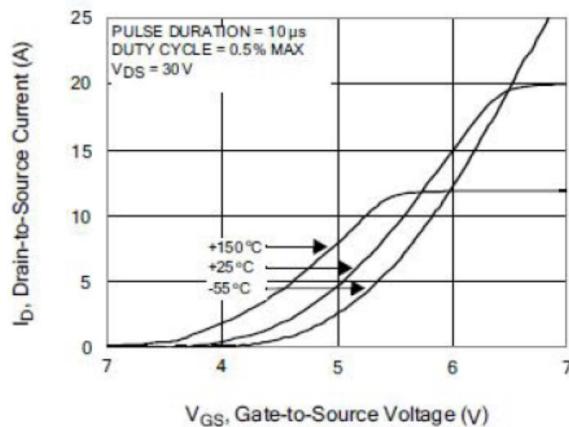


Figure 9. Typical Drain-to-Source ON Resistance vs Drain Current

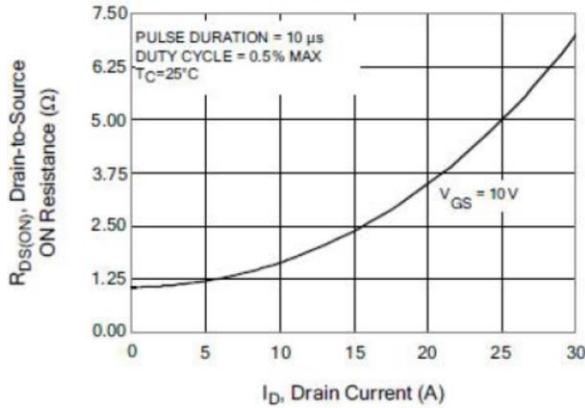


Figure 8. Unclamped Inductive Switching Capability

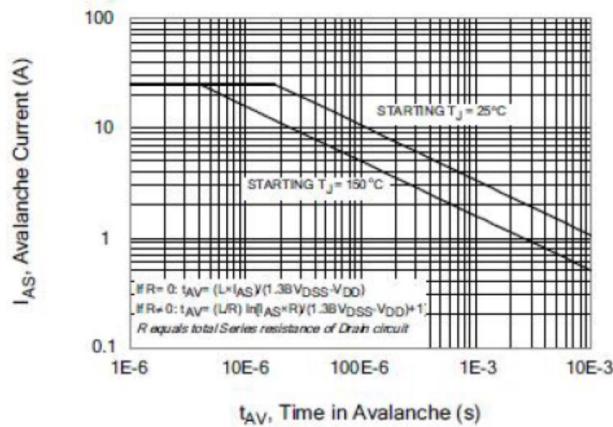


Figure 10. Typical Drain-to-Source ON Resistance vs Junction Temperature

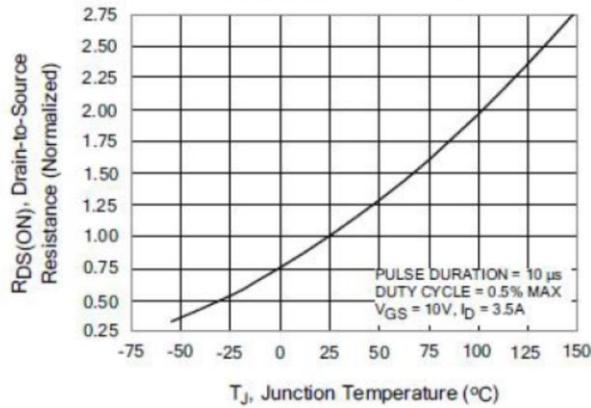




Figure 11. Typical Breakdown Voltage vs Junction Temperature

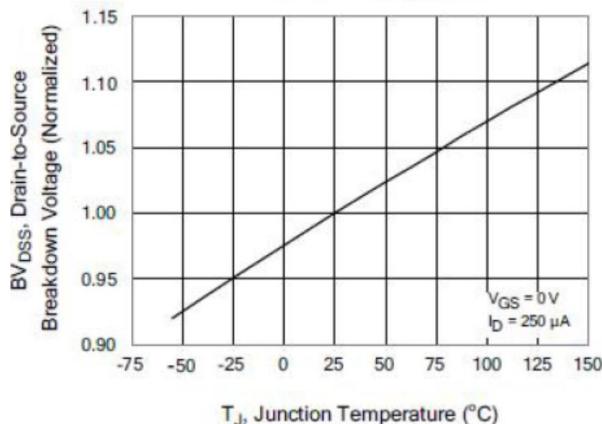


Figure 13. Maximum Forward Bias Safe Operating Area

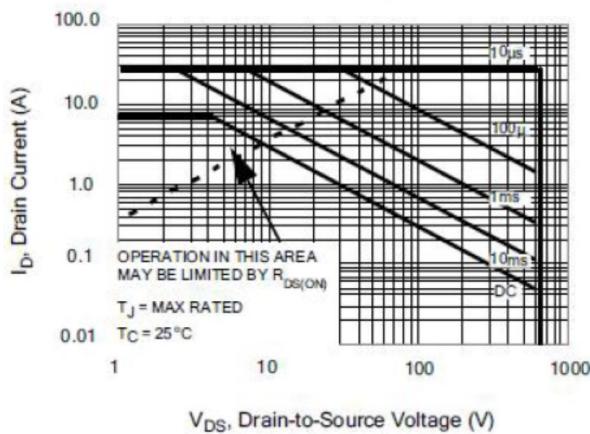


Figure 15. Typical Gate Charge vs Gate-to-Source Voltage

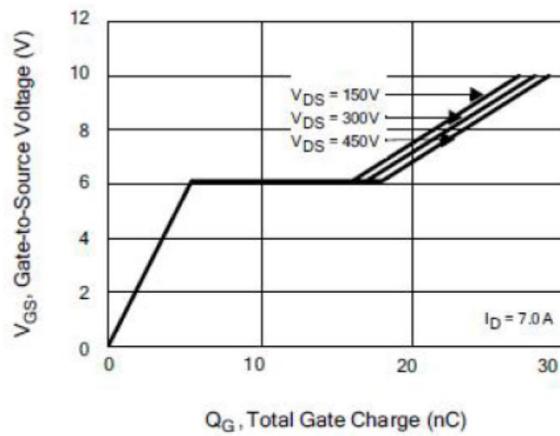


Figure 12. Typical Threshold Voltage vs Junction Temperature

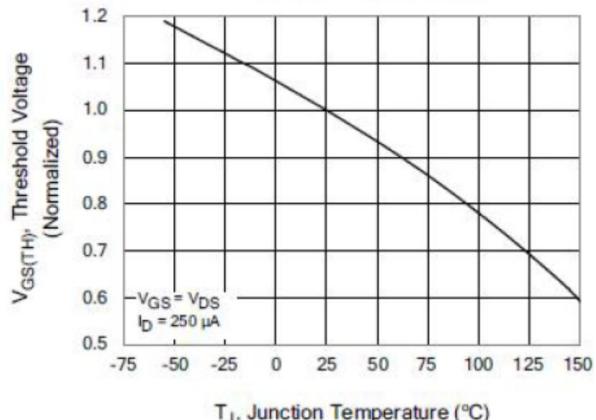


Figure 14. Typical Capacitance vs Drain-to-Source Voltage

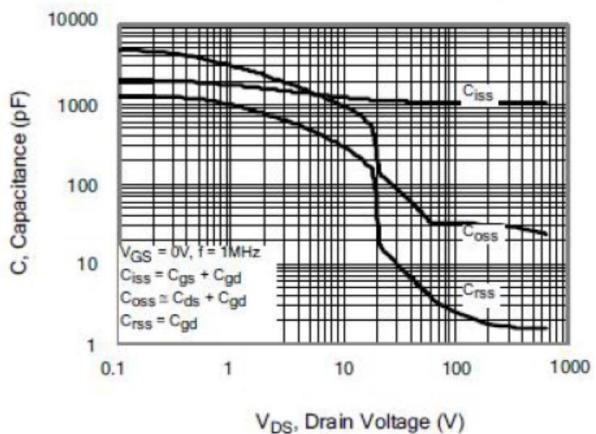
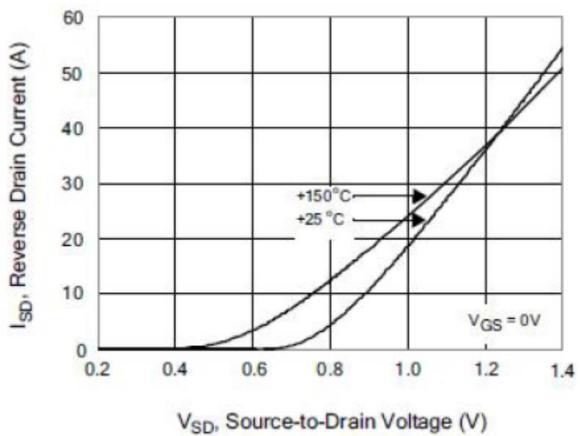


Figure 16. Typical Body Diode Transfer Characteristics

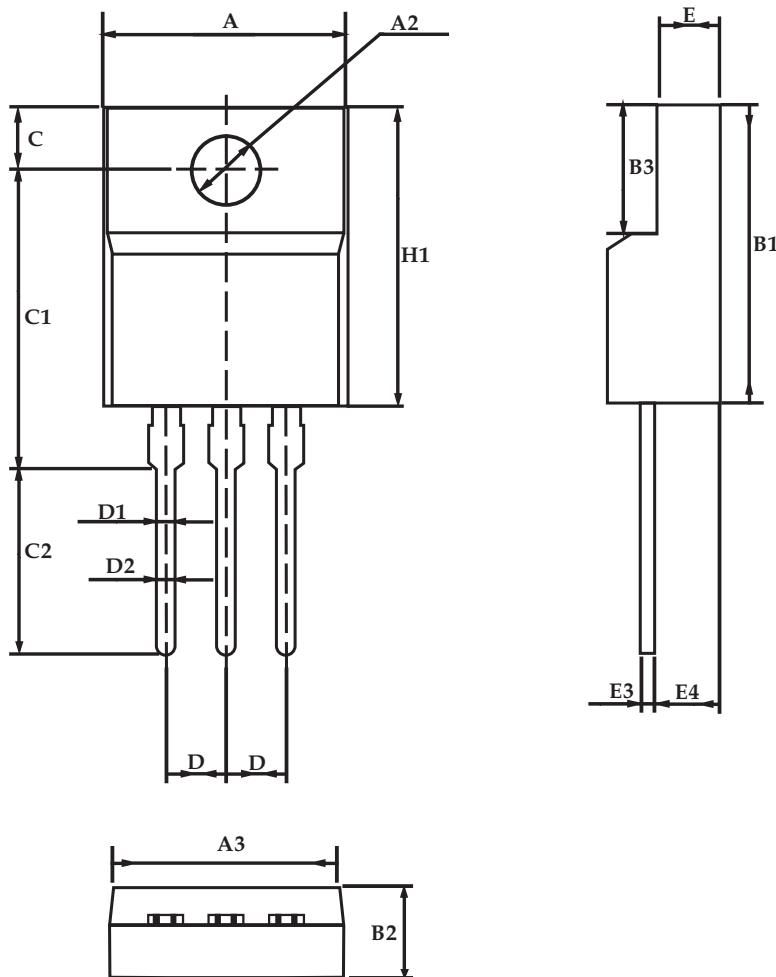




Package Outline

TO-220F
UNIT : mm

SYMBOL	min	nom	max	SYMBOL	min	nom	max
A	9.80		10.60	D		2.54	
A1		7.00		D1	1.15		1.55
A2	2.90		3.40	D2	0.60		1.00
A3	9.10		9.90	D3	0.20		0.50
B1	15.40		16.40	E	2.24		2.84
B2	4.35		4.95	E1		0.70	
B3	6.00		7.40	E2		1.0×45°	
C	3.00		3.70	E3	0.35		0.65
C1	15.00		17.00	E4	2.30		3.30
C2	8.80		10.80	α (度)		30°	



Ordering information

Device	Package	Shipping
PJM60H07NTF	TO-220F	50 PCS/TUBE